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LF444 Quad Low Power JFET Input Operational Amplifier General Description Features

The LF444 quad low power operational amplifier provides many of the same AC characteristics as the industry standard LM148 while greatly improving the DC characteristics of the LM148. The amplifier has the same bandwidth, slew rate, and gain (10 k Ω load) as the LM148 and only draws one fourth the supply current of the LM148. In addition the well matched high voltage JFET input devices of the LF444 reduce the input bias and offset currents by a factor of 10,000 over the LM148. The LF444 also has a very low equivalent input noise voltage for a low power amplifier.

The LF444 is pin compatible with the LM148 allowing an immediate 4 times reduction in power drain in many applications. The LF444 should be used wherever low power dissipation and good electrical characteristics are the major considerations.

- ¹⁄₄ supply current of a LM148: 200 µA/Amplifier (max)
- Low input bias current: 50 pA (max)
- High gain bandwidth: 1 MHz
- High slew rate: 1 V/µs
- Low noise voltage for low power 35 nV/√Hz
- Low input noise current 0.01 pA/√Hz
- High input impedance: 10¹²Ω
- High gain: 50k (min)

Simplified Schematic



Ordering Information

X indicates electrical grade

- Y indicates temperature range
- "M" for military, "C" for commercial

Z indicates package type "D", "M" or "N"

Connection Diagram



Top View Order Number LF444CM, LF444CMX, LF444ACN, LF 444CN or LF444MD/883 See NS Package Number D14E, M14A or N14A LF444 Quad Low Power JFET Input Operational Amplifier

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Absolute Maximum Ratings (Note 11)

If Military/Aerospace specified devices are required, please contact the National Semiconductor Sales Office/ Distributors for availability and specifications.

	LF44	LF444A			
Supply Voltage	±22	V	±18V		
Differential Input Voltage	±38	±38V			
Input Voltage Range	±19	V	±15V		
(Note 1)					
Output Short Circuit	Continu	uous	Continuous		
Duration (Note 2)					
	D Package	N, I	M Packages		
Power Dissipation	900 mW	670 mW			
(Notes 3, 9)					
T _j max	150°C		115°C		
θ _{iA} (Typical)	100°C/W		85°C/W		

	LF444A/LF444
Operating Temperature Range	(Note 4)
Storage Temperature Range	$-65^{\circ}C \leq T_A \leq 150^{\circ}C$
ESD Tolerance (Note 10)	Rating to
	be determined
Soldering Information	
Dual-In-Line Packages	
(Soldering, 10 sec.)	260°C
Small Outline Package	
Vapor Phase (60 sec.)	215°C
Infrared (15 sec.)	220°C

See AN-450 "Surface Mounting Methods and Their Effect on Product Reliability" for other methods of soldering surface mount devices.

DC Electrical Characteristics (Note 5)

Symbol	Parameter	Conc	Conditions		LF444A		LF444			Units
				Min	Тур	Max	Min	Тур	Max	
Vos	Input Offset Voltage	R _S = 10k, T _A =	25°C		2	5		3	10	mV
		$0^{\circ}C \le T_A \le +70$	°C			6.5			12	mV
		$-55^{\circ}C \le T_A \le +$	125°C			8				mV
$\Delta V_{OS} / \Delta T$	Average TC of Input	R _S = 10 kΩ			10			10		µV/°C
	Offset Voltage									
l _{os}	Input Offset Current	$V_{S} = \pm 15V$	T _j = 25°C		5	25		5	50	рА
		(Notes 5, 6)	$T_j = 70^{\circ}C$			1.5			1.5	nA
			T _j = 125°C			10				nA
IB	Input Bias Current	$V_{S} = \pm 15V$	T _j = 25°C		10	50		10	100	pА
		(Notes 5, 6)	T _i = 70°C			3			3	nA
			T _i = 125°C			20				nA
R _{IN}	Input Resistance	T _j = 25°C			10 ¹²			10 ¹²		Ω
A _{VOL}	Large Signal Voltage	$V_{\rm S} = \pm 15 V, V_{\rm O}$	= ±10V	50	100		25	100		V/mV
	Gain	$R_L = 10 \text{ k}\Omega, T_A$	= 25°C	1						
		Over Temperat	ure	25			15			V/mV
Vo	Output Voltage Swing	$V_{S} = \pm 15V, R_{L}$	= 10 kΩ	±12	±13		±12	±13		V
V _{CM}	Input Common-Mode			±16	+18		±11	+14		V
	Voltage Range				-17			-12		V
CMRR	Common-Mode	$R_{S} \le 10 \text{ k}\Omega$		80	100		70	95		dB
	Rejection Ratio									
PSRR	Supply Voltage	(Note 7)		80	100		70	90		dB
	Rejection Ratio									
Is	Supply Current				0.6	0.8		0.6	1.0	mA

AC Electrical Characteristics (Note 5)									
Symbol	Parameter	Conditions	LF444A		LF444			Units	
			Min	Тур	Max	Min	Тур	Max	
	Amplifier-to-Amplifier			-120			-120		dB
	Coupling								
SR	Slew Rate	$V_{\rm S} = \pm 15 V, T_{\rm A} = 25^{\circ} {\rm C}$		1			1		V/µs
GBW	Gain-Bandwidth Product	$V_{S} = \pm 15V, T_{A} = 25^{\circ}C$		1			1		MHz
e _n	Equivalent Input Noise Voltage	$T_{A} = 25^{\circ}C, R_{S} = 100\Omega,$		35			35		nV/√Hz
		f = 1 kHz							
i _n	Equivalent Input Noise Current	$T_A = 25^{\circ}C$, f = 1 kHz		0.01			0.01		pA/√Hz

Note 1: Unless otherwise specified the absolute maximum negative input voltage is equal to the negative power supply voltage.

Note 2: Any of the amplifier outputs can be shorted to ground indefinitely, however, more than one should not be simultaneously shorted as the maximum junction temperature will be exceeded.

Note 3: For operating at elevated temperature, these devices must be derated based on a thermal resistance of $\theta_{|A}$.

Note 4: The LF444A is available in both the commercial temperature range $0^{\circ}C \le T_A \le 70^{\circ}C$ and the military temperature range $-55^{\circ}C \le T_A \le 125^{\circ}C$. The LF444 is available in the commercial temperature range only. The temperature range is designated by the position just before the package type in the device number. A "C" indicates the commercial temperature range and an "M" indicates the military temperature range. The military temperature range is available in "D" package only. **Note 5:** Unless otherwise specified the specifications apply over the full temperature range and for $V_S = \pm 20V$ for the LF444A and for $V_S = \pm 15V$ for the LF444.

 V_{OS} , I_B , and I_{OS} are measured at $V_{CM} = 0$.

Note 6: The input bias currents are junction leakage currents which approximately double for every 10°C increase in the junction temperature, T_j . Due to limited production test time, the input bias currents measured are correlated to junction temperature. In normal operation the junction temperature rises above the ambient temperature as a result of internal power dissipation, P_D . $T_j = T_A + \theta_{jA}P_D$ where θ_{jA} is the thermal resistance from junction to ambient. Use of a heat sink is recommended if input bias current is to be kept to a minimum.

Note 7: Supply voltage rejection ratio is measured for both supply magnitudes increasing or decreasing simultaneously in accordance with common practice from $\pm 15V$ to $\pm 5V$ for the LF444 and from $\pm 20V$ to $\pm 5V$ for the LF444A.

Note 8: Refer to RETS444X for LF444MD military specifications.

Note 9: Max. Power Dissipation is defined by the package characteristics. Operating the part near the Max. Power Dissipation may cause the part to operate outside guaranteed limits.

Note 10: Human body model, 1.5 k Ω in series with 100 pF.

Note 11: Absolute Maximum Ratings indicate limits beyond which damage to the device may occur. Operating ratings indicate conditions for which the device is functional, but do not guarantee specific performance limits. Electrical Characteristics state DC and AC electrical specifications under particular test conditions which guarantee specific performance limits. This assumes that the device is within the Operating Ratings. Specifications are not guaranteed for parameters where no limit is given, however, the typical value is a good indication of device performance.

Typical Performance Characteristics



Input Bias Current





Typical Performance Characteristics (Continued)



00915614





VOLTAGE (V)

00915616







Positive Current Limit



Output Voltage Swing







1M 10M

10k

 $V_S = \pm 15V$ $T_A = 25^\circ C$

1M

00915631

100k

100k

00915629

00915627

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00915606





Application Hints

This device is a quad low power op amp with JFET input devices (BI-FET[™]). These JFETs have large reverse breakdown voltages from gate to source and drain eliminating the need for clamps across the inputs. Therefore, large differential input voltages can easily be accommodated without a large increase in input current. The maximum differential input voltage is independent of the supply voltages. However, neither of the input voltages should be allowed to exceed the negative supply as this will cause large currents to flow which can result in a destroyed unit.

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Application Hints (Continued)

Exceeding the negative common-mode limit on either input will force the output to a high state, potentially causing a reversal of phase to the output. Exceeding the negative common-mode limit on both inputs will force the amplifier output to a high state. In neither case does a latch occur since raising the input back within the common-mode range again puts the input stage and thus the amplifier in a normal operating mode.

Exceeding the positive common-mode limit on a single input will not change the phase of the output; however, if both inputs exceed the limit, the output of the amplifier will be forced to a high state.

The amplifiers will operate with a common-mode input voltage equal to the positive supply; however, the gain bandwidth and slew rate may be decreased in this condition. When the negative common-mode voltage swings to within 3V of the negative supply, an increase in input offset voltage may occur.

Each amplifier is individually biased to allow normal circuit operation with power supplies of ± 3.0 V. Supply voltages less than these may degrade the common-mode rejection and restrict the output voltage swing.

The amplifiers will drive a 10 k Ω load resistance to ±10V over the full temperature range. If the amplifier is forced to drive heavier load currents, however, an increase in input offset voltage may occur on the negative voltage swing and finally reach an active current limit on both positive and negative swings.

Precautions should be taken to ensure that the power supply for the integrated circuit never becomes reversed in polarity or that the unit is not inadvertently installed backwards in a socket as an unlimited current surge through the resulting forward diode within the IC could cause fusing of the internal conductors and result in a destroyed unit.

As with most amplifiers, care should be taken with lead dress, component placement and supply decoupling in order to ensure stability. For example, resistors from the output to an input should be placed with the body close to the input to minimize "pick-up" and maximize the frequency of the feedback pole by minimizing the capacitance from the input to ground.

A feedback pole is created when the feedback around any amplifier is resistive. The parallel resistance and capacitance from the input of the device (usually the inverting input) to AC ground set the frequency of the pole. In many instances the frequency of this pole is much greater than the expected 3 dB frequency of the closed loop gain and consequently there is negligible effect on stability margin. However, if the feedback pole is less than approximately 6 times the expected 3 dB frequency a lead capacitor should be placed from the output to the input of the op amp. The value of the added capacitor should be such that the RC time constant of this capacitor and the resistance it parallels is greater than or equal to the original feedback pole time constant.

Typical Application

pH Probe Amplifier/Temperature Compensator



***For R2 = 50k, R4 = 330k $\pm 1\%$

For R2 = 100k, R4 = 75k \pm 1%

For R2 = 200k, R4 = 56k $\pm 1\%$

**Polystyrene

*Film resistor type RN60C

To calibrate, insert probe in pH =7 solution. Set the "TEMPERATURE ADJUST" pot, R2, to correspond to the solution temperature: full clockwise for 0°C, and proportionately for intermediate temperatures, using a turns-counting dial. Then set "CALIBRATE" pot so output reads 7V.

00915610

Typical probe = Ingold Electrodes #465-35

LF444

Detailed Schematic



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Physical Dimensions inches (millimeters) unless otherwise noted





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